

Notice of References Cited	Application/Control No. 10/783,619	Applicant(s)/Patent Under Reexamination FUNG ET AL.	
	Examiner QIUWEN MI	Art Unit 1655	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

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	N	JP 62108844 A	05-1987	Japan	IKETANI et al.	-----
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NON-PATENT DOCUMENTS

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